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| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination FANG, TE-HSIANG | |
| | | Examiner David J. Makiya | Art Unit 2875 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------------|----------------|
| | A | US-1,205,628 A | 11-1916 | Hitzelberger, Gustave | 200/60 |
| | B | US-4,699,536 A | 10-1987 | Berman, James | 401/88 |
| | C | US-6,299,372 B1 | 10-2001 | Wang, Kuan Yun | 401/195 |
| | D | US-6,585,388 B2 | 07-2003 | Kim, Jin-woong | 362/118 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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